

N- Channel Enhancement Mode Power MOSFET

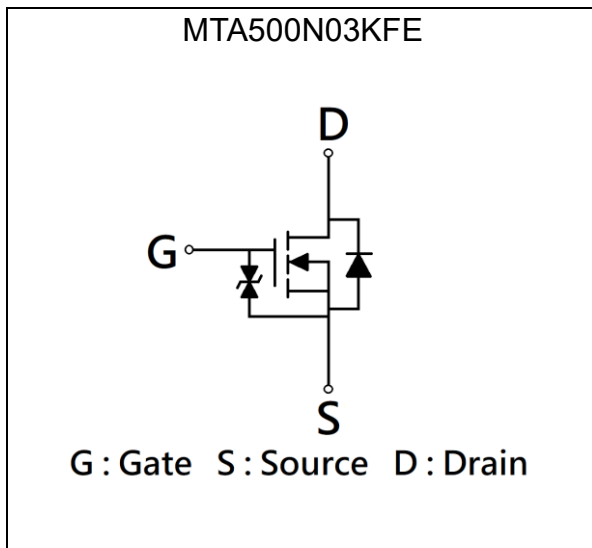
MTA500N03KFE

Features

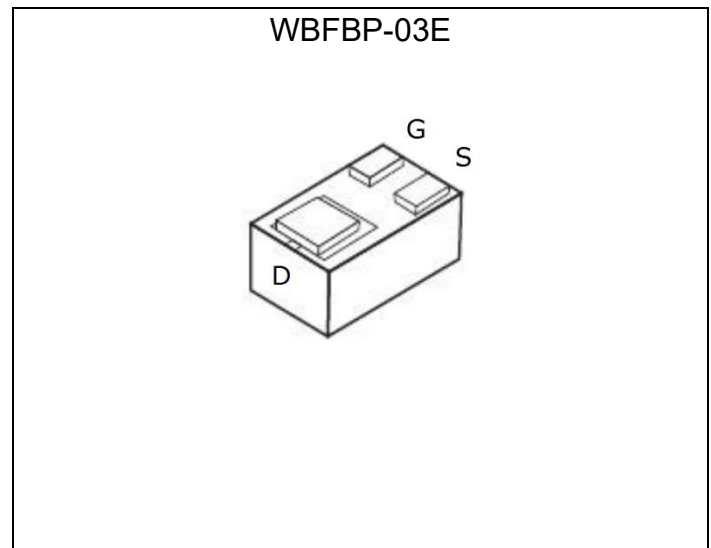
- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic
- ESD protected gate, typical 4kV (HBM)

BV_{DSS}	30V
$I_D@V_{GS}=4.5V, T_A=25^{\circ}C$	0.86A
$R_{DS(ON)}$ typ. @ $V_{GS}=4.5V, I_D=0.2A$	0.5Ω
$R_{DS(ON)}$ typ. @ $V_{GS}=2.5V, I_D=0.2A$	0.6Ω
$R_{DS(ON)}$ typ. @ $V_{GS}=1.8V, I_D=10mA$	0.9Ω

Equivalent Circuit

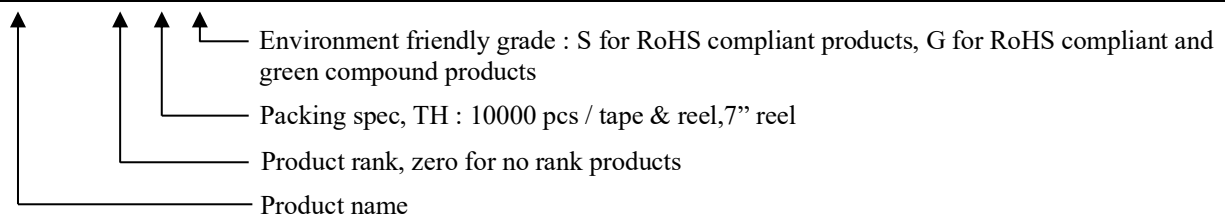


Outline



Ordering Information

Device	Package	Shipping
MTA500N03KFE-0-TH-G	WBFBP-03E (Pb-free lead plating and halogen-free package)	10000 pcs / Tape & Reel



**Absolute Maximum Ratings (T_A=25°C)**

Parameter	Symbol	Limits	Unit	
Drain-Source Voltage	V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	±8		
Continuous Drain Current @ V _{GS} =4.5V, T _A =25°C	I _D	0.86	A	
Continuous Drain Current @ V _{GS} =4.5V, T _A =70°C		0.69		
Pulsed Drain Current *a	I _{DM}	2.2		
Continuous Body Diode Forward Current @ T _A =25°C	I _S	0.75		
Pulsed Body Diode Forward Current	I _{SM}	2.2		
ESD susceptibility *b	V _{ESD}	4000	V	
Total Power Dissipation	P _D	T _A =25°C	0.9	W
		T _A =70°C	0.6	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55~+150	°C	

Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-ambient	R _{θJA}	136	°C/W

Note:

*a. Repetitive rating, pulse width limited by junction temperature T_J(MAX)=150°C. Ratings are based on low frequency and low duty cycles to keep initial T_J=25°C.

*b. Human body model, 1.5kΩ in series with 100pF.



Electrical Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	0.4	-	1.2		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	0.8	-	S	V _{DS} =5V, I _D =0.2A
I _{GSS}	-	-	±10	μA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	1		V _{DS} =24V, V _{GS} =0V
R _{DS(ON)}	-	0.5	0.7	Ω	V _{GS} =4.5V, I _D =0.2A
	-	0.6	0.9		V _{GS} =2.5V, I _D =0.2A
	-	0.9	2		V _{GS} =1.8V, I _D =10mA
Dynamic					
C _{iss}	-	31	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	11	-		
C _{rss}	-	8	-		
Q _g *1, 2	-	0.9	-	nC	V _{DS} =20V, I _D =0.2A, V _{GS} =4.5V
Q _{gs} *1, 2	-	0.2	-		
Q _{gd} *1, 2	-	0.2	-		
t _{d(ON)} *1, 2	-	5.3	-	ns	V _{DS} =15V, I _D =0.2A, V _{GS} =4.5V, R _{GS} =6Ω
t _r *1, 2	-	16	-		
t _{d(OFF)} *1, 2	-	20	-		
t _f *1, 2	-	18	-		
Source-Drain Diode					
V _{SD} *1	-	0.85	1.2	V	I _S =0.2A, V _{GS} =0V
t _{rr}	-	4.7	-	ns	I _F =0.5A, dI _F /dt=100A/μs
Q _{rr}	-	1.2	-	nC	

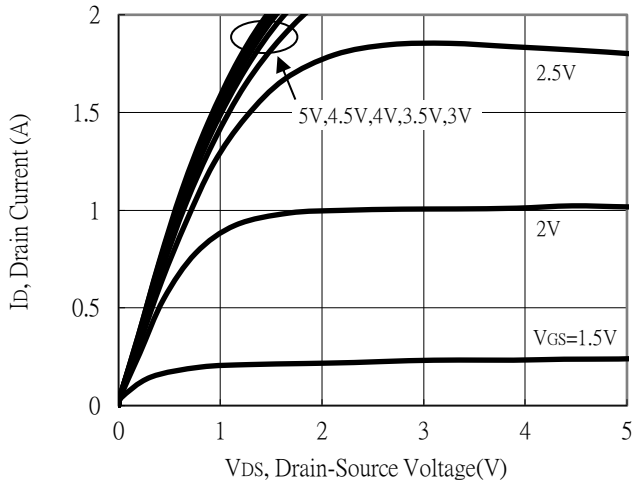
Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

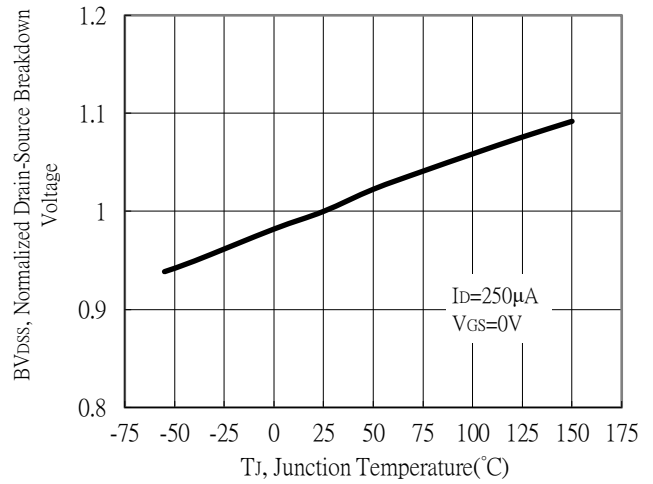
*2. Independent of operating temperature

Typical Characteristics

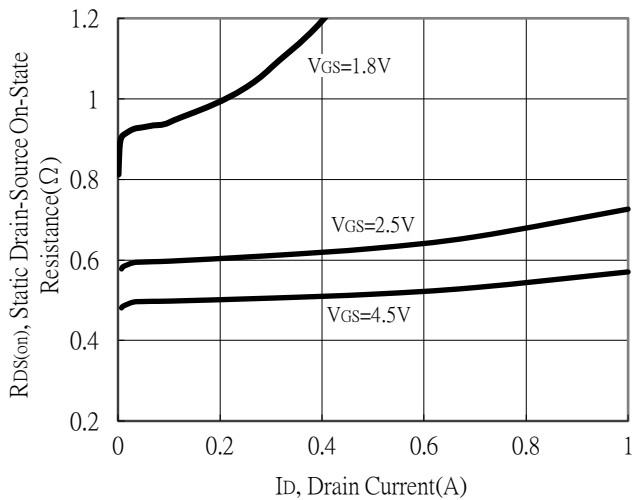
Typical Output Characteristics



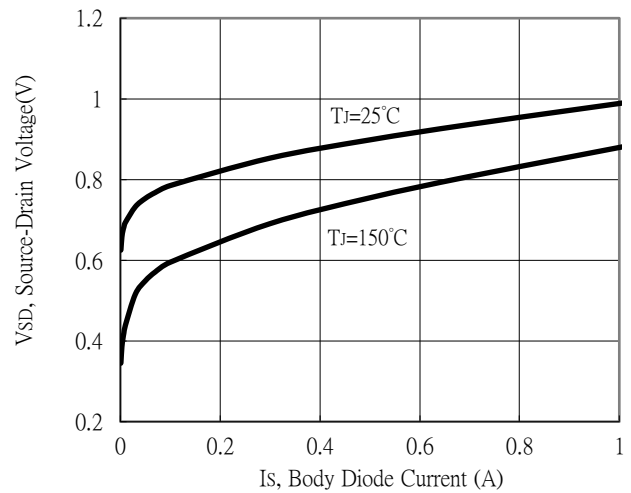
Breakdown Voltage vs Ambient Temperature



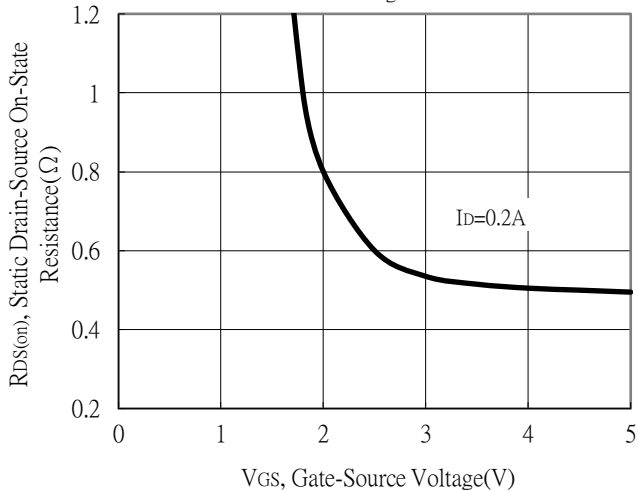
Static Drain-Source On-State resistance vs Drain Current



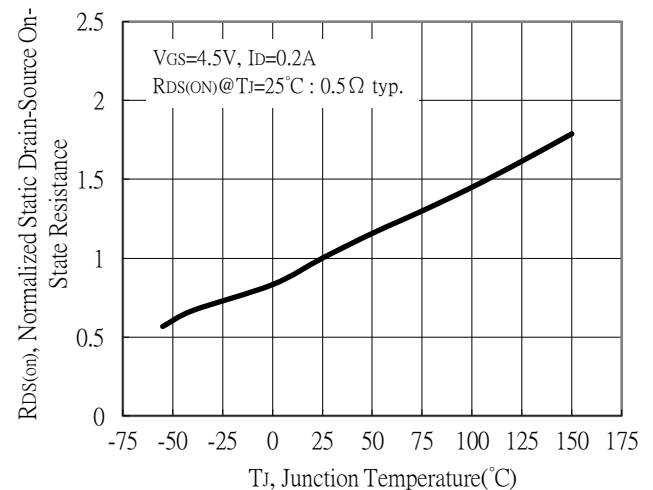
Body Diode Current vs Source-Drain Voltage



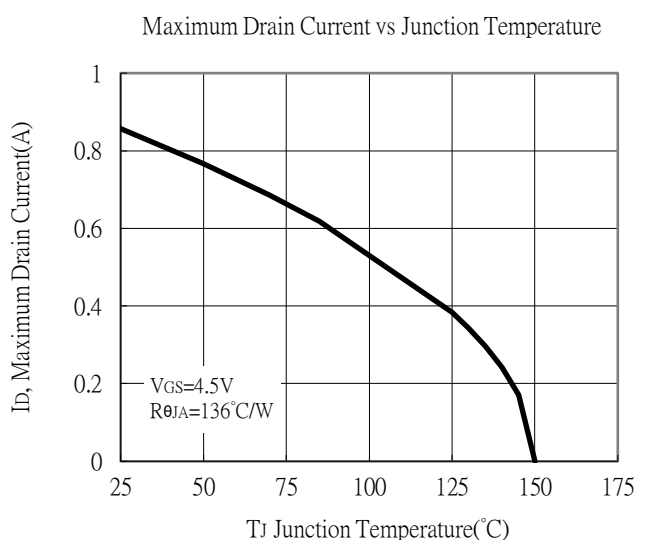
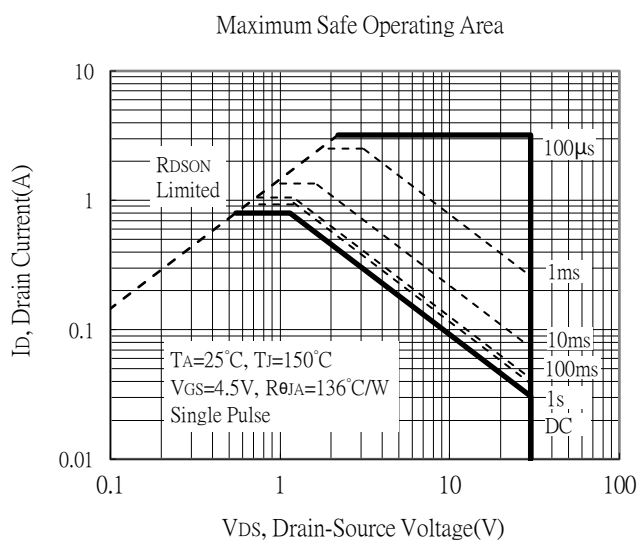
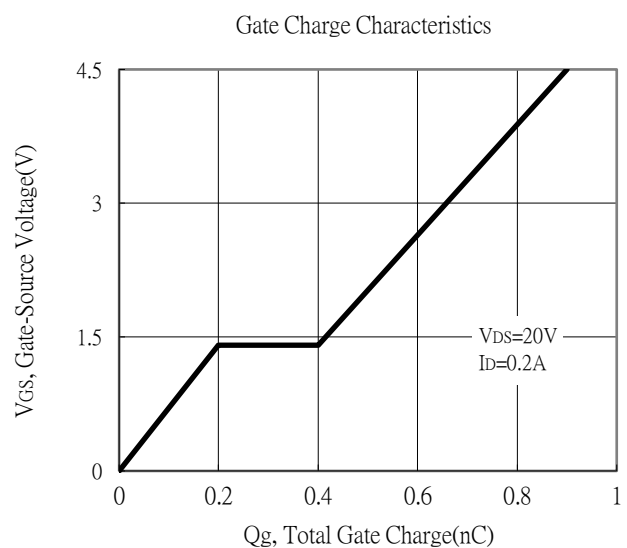
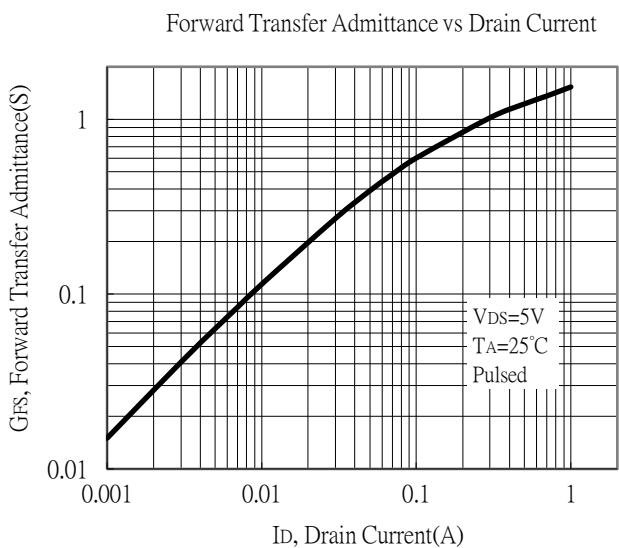
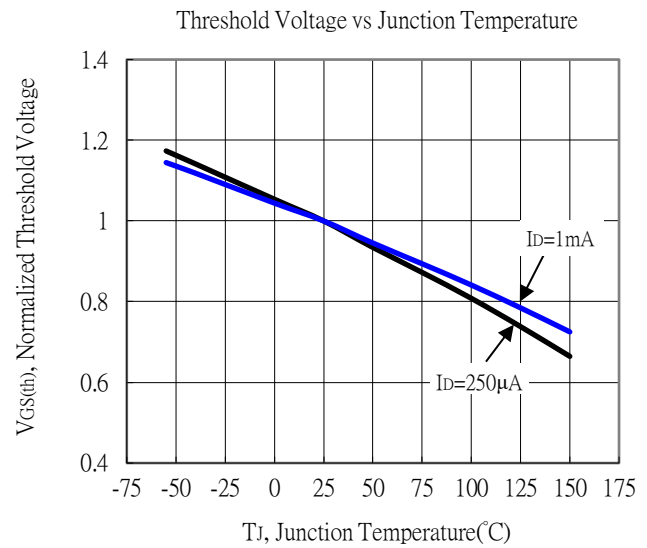
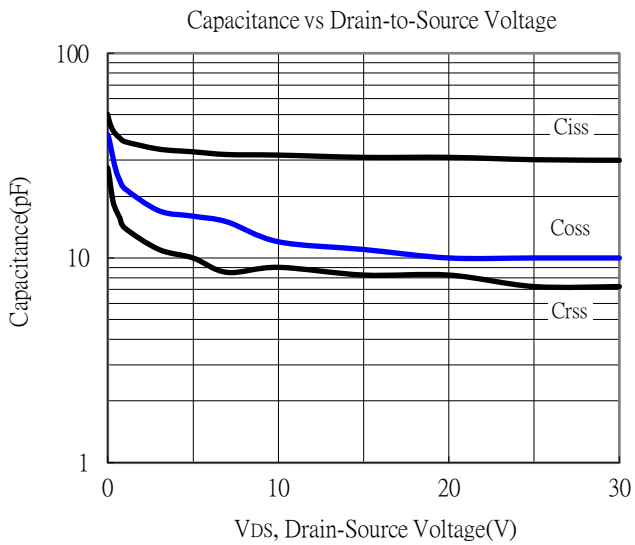
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

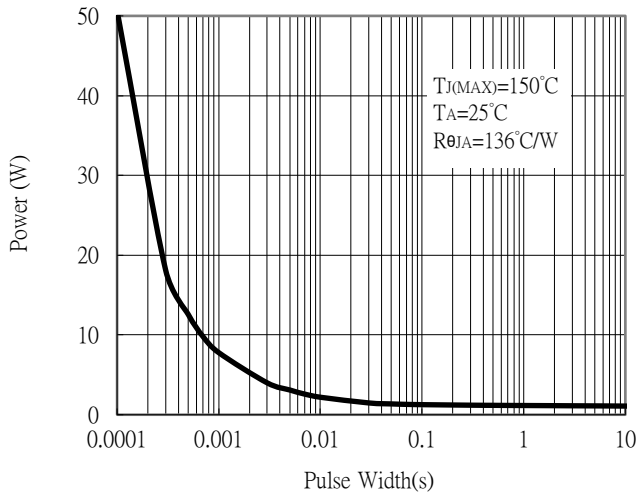


Typical Characteristics (Cont.)

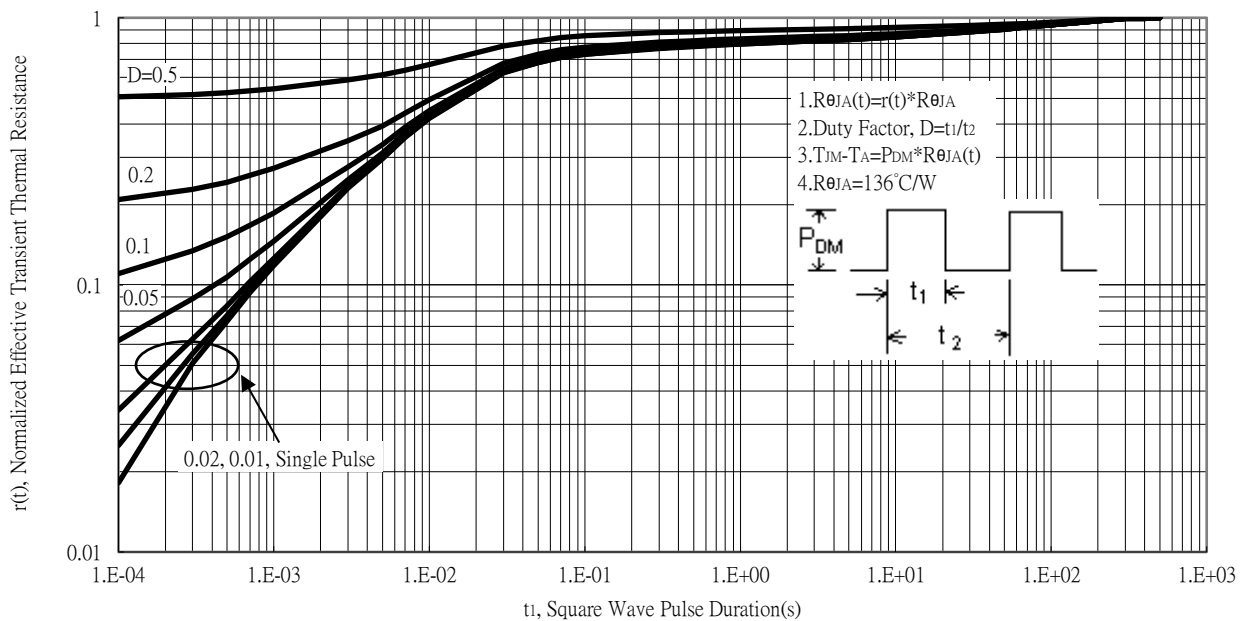


Typical Characteristics (Cont.)

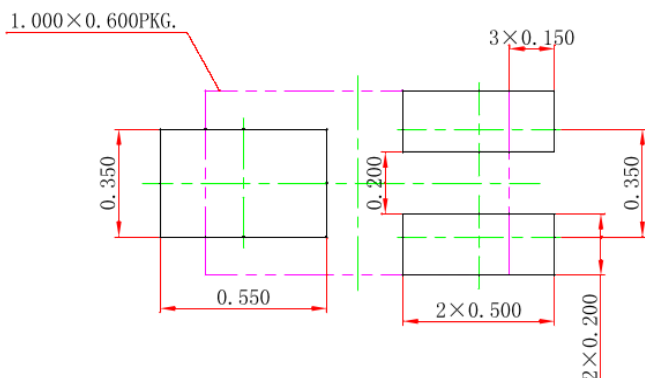
Single Pulse Power Rating, Junction to Ambient



Transient Thermal Response Curves



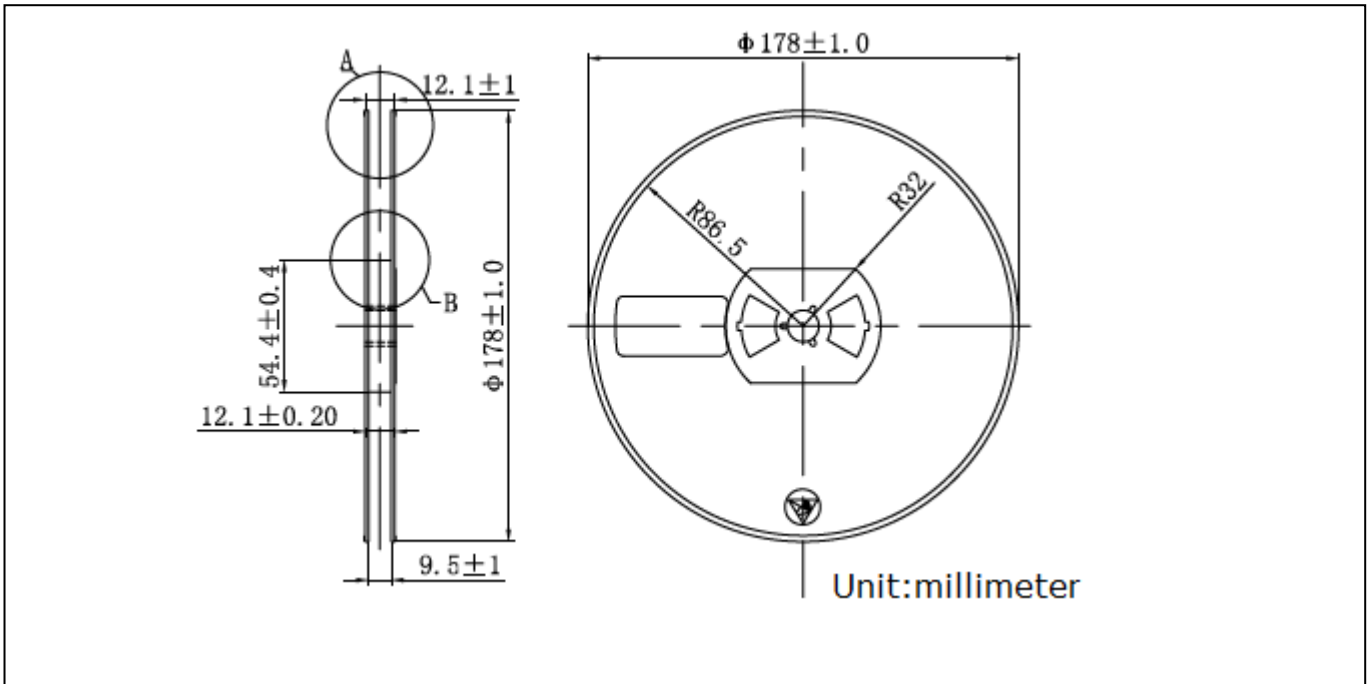
Recommended Soldering Footprint



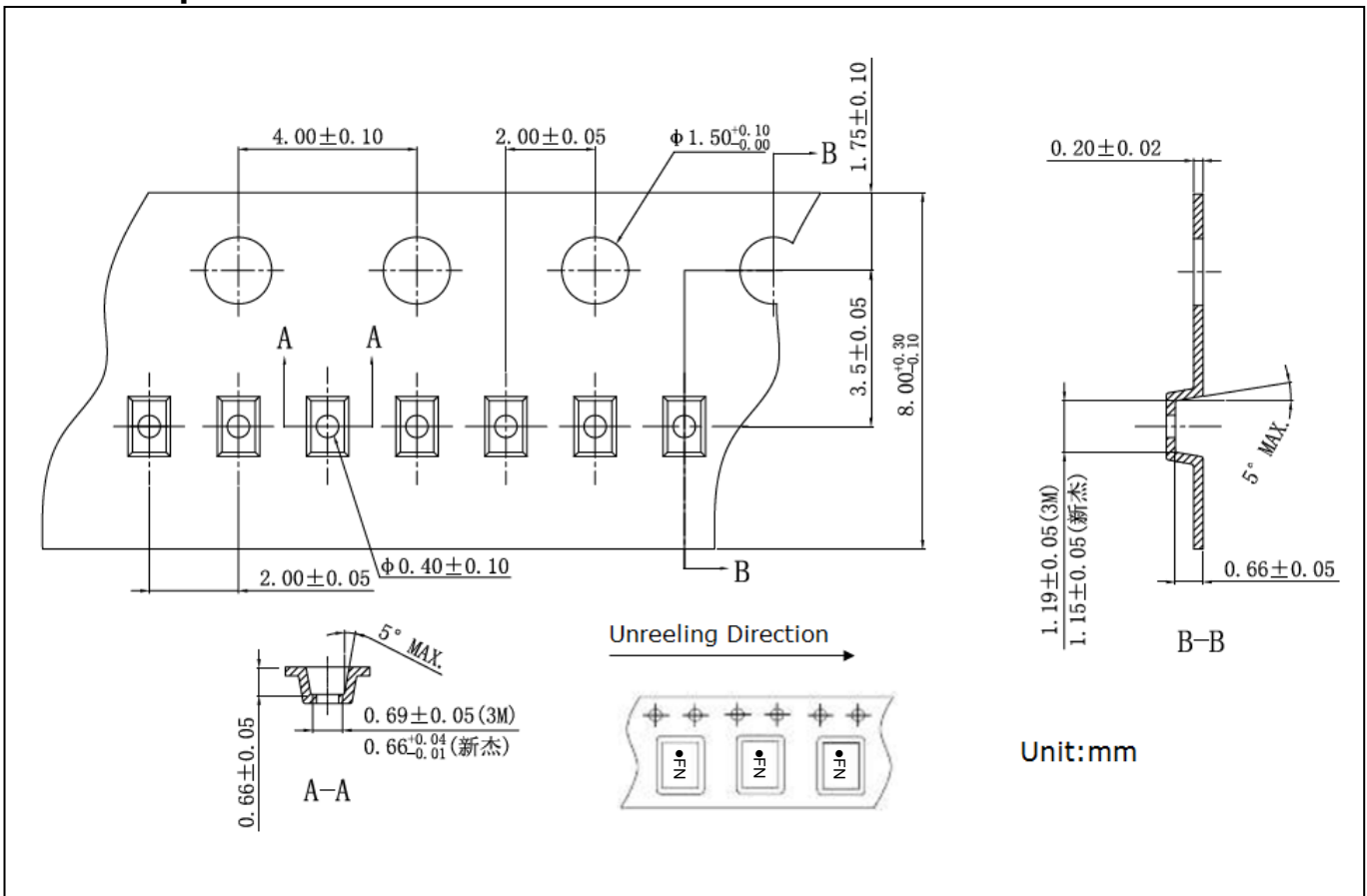
Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.050mm$.
3. The pad layout is for reference purposes only.

Reel Dimension



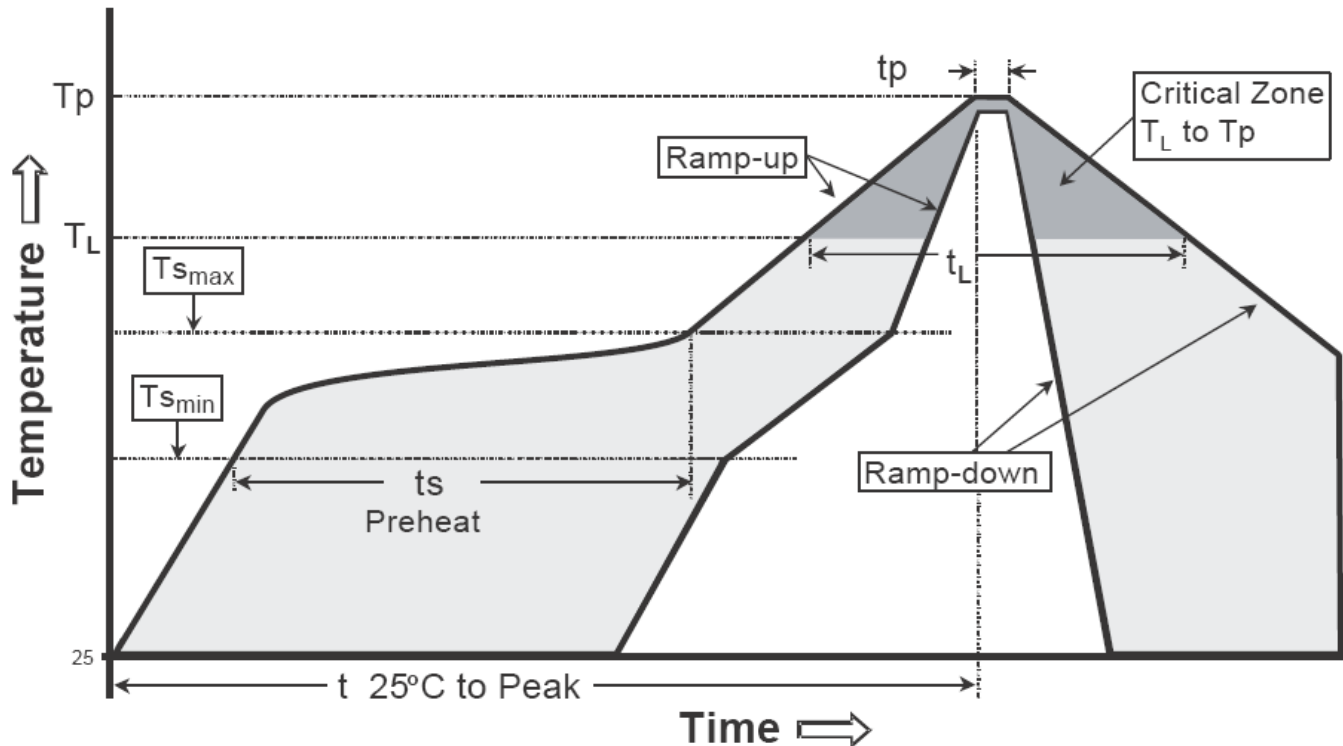
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

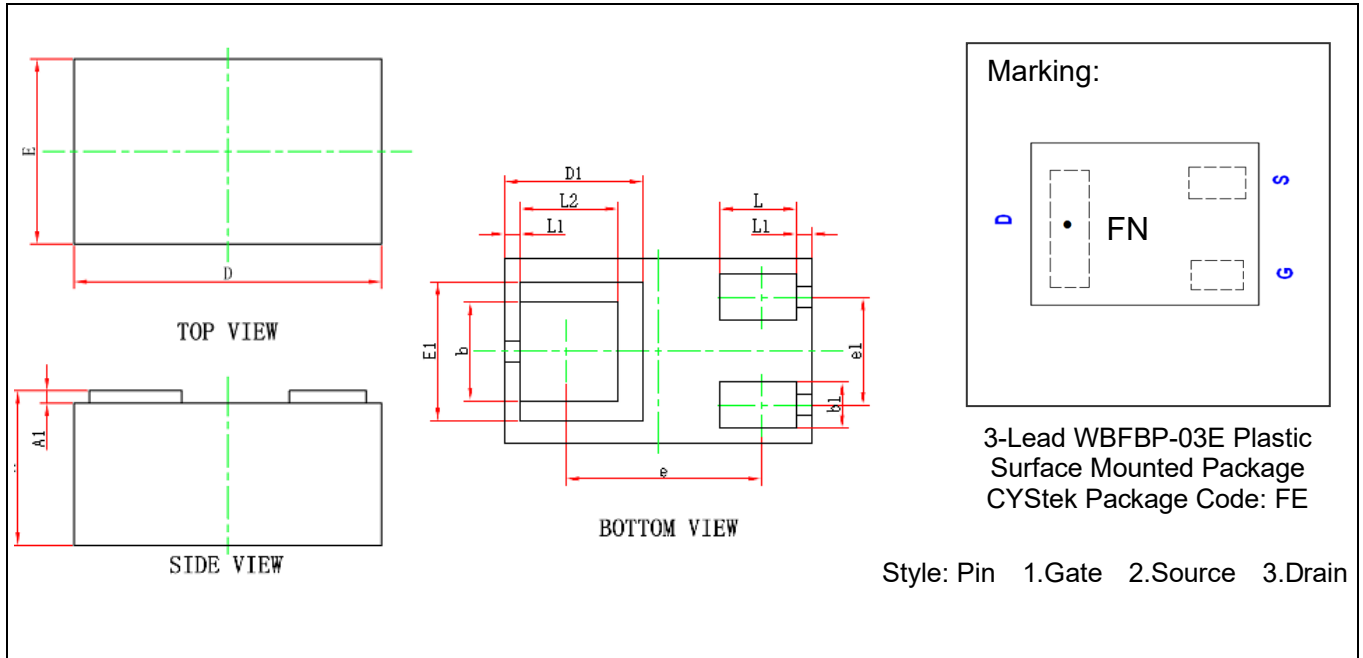
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

WBFBP-03E Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.018	0.022	0.450	0.550	b1	0.004	0.008	0.100	0.200
A1	0.000	0.004	0.010	0.100	e	0.025 REF		0.635 REF	
D	0.037	0.041	0.950	1.050	e1	0.012	0.016	0.300	0.400
E	0.022	0.026	0.550	0.650	L	0.008	0.012	0.200	0.300
D1	0.018 REF		0.450 REF		L1	0.002 REF		0.050 REF	
E1	0.018 REF		0.450 REF		L2	0.011	0.015	0.270	0.370
b	0.011	0.015	0.270	0.370					

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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